WHICH QUANTUM CIRCUIT MUTANTS SHALL BE USED? AN EMPIRICAL EVALUATION OF QUANTUM CIRCUIT MUTATIONS

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ABSTRACT

As a new research area, quantum software testing lacks systematic testing benchmarks to assess testing techniques' effectiveness. Recently, some open-source benchmarks and mutation analysis tools have emerged. However, there is insufficient evidence on how various quantum circuit characteristics (e.g., circuit depth, number of quantum gates), algorithms (e.g., Quantum Approximate Optimization Algorithm), and mutation characteristics (e.g., mutation operators) affect the detection of mutants in quantum circuits. Studying such relations is important to systematically design faulty benchmarks with varied attributes (e.g., the difficulty in detecting a seeded fault) to facilitate assessing the cost-effectiveness of quantum software testing techniques efficiently. To this end, we present a large-scale empirical evaluation with more than 700K faulty benchmarks (quantum circuits) generated by mutating 382 real-world quantum circuits. Based on the results, we provide valuable insights for researchers to define systematic quantum mutation analysis techniques. We also provide a tool to recommend mutants to users based on chosen characteristics (e.g., a quantum algorithm type) and the required difficulty of detecting mutants. Finally, we also provide faulty benchmarks that can already be used to assess the cost-effectiveness of quantum software testing techniques.

*K*eywords quantum software testing, mutation analysis, benchmarks, quantum circuit

1 Introduction

Quantum Computing (QC) is a fairly recent field that is advancing quickly [\[1\]](#page-16-0), promising to revolutionize computing by offering solutions to some complex problems with the enormous computational power of quantum computers. Quantum software empowers the QC application development [\[2\]](#page-16-1). Naturally, there is a growing need to test quantum software to assess quantum software's correctness. To this end, several quantum software testing techniques have emerged in the last few years [\[3,](#page-16-2) [4,](#page-16-3) [5,](#page-16-4) [6,](#page-16-5) [7,](#page-16-6) [8,](#page-16-7) [9,](#page-16-8) [10,](#page-16-9) [11\]](#page-16-10).

Quantum software testing techniques need benchmarks to assess their cost-effectiveness. To this end, some open-source benchmarks appeared recently [\[12,](#page-16-11) [13,](#page-17-0) [14,](#page-17-1) [15\]](#page-17-2). However, such benchmarks are small-scale and do not provide systematic classifications of bug features that could be used to systematically assess the effectiveness of quantum software testing techniques. At the same time, some quantum mutation analysis techniques with tools have been published recently [\[16,](#page-17-3) [5,](#page-16-4) [7,](#page-16-6) [8\]](#page-16-7). However, these tools generate too many mutants, which become infeasible to execute due to scarce QC resources. Even if the execution is not an issue, many mutants generated by these tools are redundant and are often too easy to detect; thereby, they are not useful for testing. Finally, these tools do not provide a systematic and intelligent way to generate a small subset of mutants with varied characteristics such that quantum mutation testing techniques can be assessed more systematically.

In general, there is no sufficient understanding of quantum mutations, e.g., *which mutants* are difficult to detect, *where to seed* a fault in a quantum circuit so that it is difficult to detect, and *which types* of mutations are related to each algorithm type. To build such understanding, to generate new knowledge about quantum mutants, and to generate faulty benchmarks of different characteristics to systematically and efficiently assess the cost-effectiveness of quantum software testing techniques, we present results of a large-scale empirical evaluation with more than 700K faulty benchmarks generated with an existing quantum mutation analysis tool [\[16\]](#page-17-3). Each generated benchmark is a faulty version of an original quantum circuit and is called *faulty benchmark*.

This empirical evaluation aims to study various mutation characteristics (e.g., mutation operator types, gate types, position), quantum algorithms and their classification (e.g., Variational Quantum Eigensolver, Amplitude Estimation, Grover's algorithm), and circuit characteristics (e.g., circuit depth, the number of gates, number of entangled qubits) on the "survivability" of faulty benchmarks, i.e., whether the fault seeded in a benchmark can survive the fault detection of a quantum software testing technique. Our motivation for choosing survivability is that we want to assess the difficulty of detecting a seeded fault. To this end, such survivability indicates how various mutation and circuit characteristics, and quantum algorithms and their classification, play a role in the effectiveness of detecting the fault in a faulty benchmark with a given quantum software testing technique.

Based on the results, key observations are: First, we found that faulty benchmarks generated with the adding mutation operator (i.e., adding a new quantum gate) have higher survivability than removing or replacing a quantum gate from a circuit. Second, regarding the position where a mutation operator is applied to create a faulty benchmark, mutating at the beginning or the end of the circuit leads to higher survivability, concluding that mutating the middle part of the circuit will likely change circuit behavior. Third, survivability is strongly related to the algorithm used. Notably, the algorithms that are designed to produce one dominant output, i.e., output with the highest probability (e.g., optimization algorithms), are likely to lead to high survival rates. Finally, we also found no significant correlation between the circuit complexity characteristics (e.g., the number of qubits in a circuit) and survivability.

Our main contribution is a comprehensive empirical study to generate new knowledge on understanding relationships of mutation characteristics, circuit characteristics, quantum algorithms, and their interactions with the survivability of faulty benchmarks. Additionally, based on the results of the empirical study, we provide a command line-based recommendation tool to assist users in generating a desired number of faulty benchmarks of varied survivabilities by considering characteristics of interested quantum algorithms. Finally, we provide a large-scale faulty benchmark consisting of more than 700K faulty benchmark circuits that can be readily used to assess the cost-effectiveness of quantum software testing techniques. All detailed experiment results, code, and data are provided in the online repository [\[17\]](#page-17-4).

Paper structure: Section [2](#page-1-0) and Section [3](#page-3-0) present the background and related work, respectively. We present the design of the empirical study in Section [4,](#page-4-0) and results and discussion in Section [5.](#page-9-0) We conclude the paper in Section [6.](#page-16-12)

2 Background

Quantum Computing. The main difference between a quantum computer and a classical computer is the smallest data unit on which they perform computations. Such data unit in classical computing is a bit, whereas, in Quantum Computing (QC), it is a quantum bit (qubit). A classical bit can only have a value of 0 or 1 at a given time point, whereas a qubit can be in a *superposition* state of 0 and 1. Superposition is one of the special quantum characteristics leading to quantum speedup. Another key quantum characteristic is *entanglement*, where two or more qubits are connected to each other, i.e., they will always be in the same state [\[18\]](#page-17-5). Another special characteristic of QC is that it obeys the *no-cloning theorem* [\[19\]](#page-17-6), i.e., one cannot simply copy or measure a quantum state since it will result in collapsing a quantum state from a superposition state to a definite state (classical state) [\[20\]](#page-17-7). In QC, the collapse of a qubit is used to obtain the measurement result of a quantum operation [\[20\]](#page-17-7).

Figure [1](#page-2-0) shows an example of a quantum circuit visually drawn in IBM's quantum circuit composer [\[21\]](#page-17-8). It shows the key elements of the circuit having five qubits $(q[0]$ to $q[4]$) and a group of five classical bits, i.e., c_5 . A quantum circuit performs computations with quantum gates on qubits. A quantum gate takes qubit(s) as inputs and performs computation to alter the state of the quantum circuit. If a quantum gate operates on one qubit, we call it a *Single Qubit Gate*, e.g., a Hadamard gate (*H*). The Hadamard gate is represented as a square with an *H* in Figure [1,](#page-2-0) and is the gate used to put a qubit in a superposition state. A *Multi-qubit Gate* operates on more than one qubit (e.g., conditional NOT gate (CNOT), where the control qubit is symbolized with a small filled circle, and the target qubit symbolized with a + sign within a circle). The conditional gates apply the operation of the gate only when the control qubit state is 1. In the case of the CNOT gate, the NOT operation is applied only if the conditional qubit's state is 1, flipping the state of the target qubit. At the end of the circuit the measurements are shown. A measurement collapses the state of the qubit into a classical definite state, i.e., the quantum state is translated into a classical state and cannot be translated back to the quantum state.

Classic Software Testing VS Quantum Software Testing. In classical software engineering, software testing has long been established as a fundamental aspect of ensuring the quality and reliability of software systems. Over the years, diverse testing techniques have been developed, ranging from basic unit testing to more sophisticated approaches such as model-based testing

Figure 1: A quantum circuit example. The circuit has five qubits (i.e., $q[0]$ to $q[4]$) and a group of five classical bits (i.e., together denoted as c_5). The measurements collapse the state of all qubits to classical bits. The three selected operators are: *Add* a gate before position 8 in the circuit, *Remove* the Hadamard gate at position 0, and *Replace* the NOT gate with a Hadamard gate at position 13.

and regression testing [\[22\]](#page-17-9). Through systematic testing, software testers can detect and correct defects, enhancing their software system's functionality and robustness.

Quantum software, operating under distinct properties, such as quantum superposition, entanglement, and no-cloning, presents unique challenges when devising testing techniques for quantum software. For instance, the no-cloning theorem prohibits the creation of independent copies of unknown quantum states, restricting the ability to inspect and copy internal program states during execution, commonly used in classical software testing and debugging. This limitation makes checking precise test oracles harder, as most traditional methods are based on state inspection, which in the case of quantum software results in collapsing quantum software's superposition. Testing techniques must adapt to these properties, ensuring effectiveness even being unable to directly observe and analyze quantum states during execution [\[2,](#page-16-1) [23,](#page-17-10) [24\]](#page-17-11).

Mutation Analysis. Mutation analysis is a widely used technique in software engineering to evaluate the effectiveness and quality of testing techniques. A typical mutation analysis process systematically uses mutation operators to introduce changes to the correct program. As a result, each change produces a faulty version (*mutant*) of the program. Test cases are executed on mutants to determine which test cases can detect the mutants. The testing results measure the adequacy of testing techniques used to generate test cases [\[25\]](#page-17-12).

The mutants can have different behaviors depending on the operator applied and the program itself. Within this context, each mutant can be categorized into several groups. First, regarding whether the testing technique can detect it or not, a mutant is classified as *detected* (or *killed*), or as a *survivor*, i.e., not detected. On the other hand, those mutants that are not even able to be executed, due to some syntactical errors, are called the *stillborn* mutants [\[26\]](#page-17-13).

Each group is further divided into some subcategories. Inside the not-detected mutants, one of the main challenges of mutation analysis is related to *equivalent mutants*. Equivalent mutants are those that behave the same as the original program for all the inputs, thus, they cannot be detected by any test. Moreover, another critical category is constituted by *redundant mutants* that make minimal contributions to the testing process. Those are the ones that are detected whenever other mutants are detected. This category includes *duplicated* mutants, which are equivalent to each other but not to the original program, and *subsumed* mutants, jointly detected when other mutants are detected. Any error detected in a *subsumed* mutant is also identified by the first mutant [\[27,](#page-17-14) [28,](#page-17-15) [29,](#page-17-16) [30\]](#page-17-17).

Classically, each detected mutant is also categorized depending on its strength. *Weakly detected mutants* that expose differences in the program state immediately after execution compared to the execution of the original program; *firmly detected mutants* that expose differences at a later point; and *strongly detected mutants* that show observable differences in the outputs [\[22\]](#page-17-9).

Quantum Mutation Analysis. In quantum mutation analysis, we introduce faults in quantum circuits by introducing small changes at the quantum gate level. For instance, those faults can be introduced by adding, removing, or replacing quantum gates in an original quantum circuit. These are referred to as *mutation operator types* in [\[16\]](#page-17-3). Figure [1](#page-2-0) shows some examples of these operator types: replacing a NOT gate (*+*) with a Hadamard gate (*H*), deleting a Hadamard gate (*H*), and adding any gate in a given position. Such a way of creating faulty versions of quantum circuits for assessing testing techniques has been performed in some existing works of quantum software testing [\[4,](#page-16-3) [3,](#page-16-2) [31,](#page-17-18) [16,](#page-17-3) [5,](#page-16-4) [7,](#page-16-6) [8\]](#page-16-7).

Another important characteristic is the *gate type*, introduced in [\[16\]](#page-17-3). *Gate type* refers to the quantum gate present in the change applied to the circuit, i.e., we can add any quantum gate in a quantum circuit, whereas we can delete or replace only quantum gates that are already present in the quantum circuit. The third characteristic is the *position*, which refers to a particular place in the quantum circuit where a fault can be introduced. Each of the gates in the circuit is located in a specific position. When applying an operator, a position of the circuit is chosen, and depending on the change that is wanted, the change is applied in the gate linked to that position (Remove or Replace) or before the gate related to that position (Add). The position of a gate is determined by the order of the statements in the code. The first position refers to the first gate applied to the circuit, whereas the last position of the circuit is the last gate before the measurements. In Figure [1](#page-2-0) the position of each gate is indicated with a number, e.g., removing a Hadamard gate in position 0, adding a new gate in position 8, or replacing a NOT gate with a Hadamard gate in position 13. Further details can be consulted in [\[16\]](#page-17-3).

3 Related Work

Classic Mutation Analysis. The surveys of Jia and Harman [\[32\]](#page-17-19) and Papadakis et al. [\[33\]](#page-17-20) show the growing interest of the research community in mutation analysis. Inside mutation analysis, in order to improve and adapt the mutation to different use cases, several different strategies have been developed. Some of them involve new mutant generation techniques or new mutant selection strategies [\[32,](#page-17-19) [33\]](#page-17-20). Different works have proposed operators for specific programming languages [\[34,](#page-17-21) [35,](#page-17-22) [36,](#page-18-0) [37,](#page-18-1) [38\]](#page-18-2), categories of programming languages [\[39,](#page-18-3) [40,](#page-18-4) [41,](#page-18-5) [42\]](#page-18-6), categories of applications [\[43,](#page-18-7) [44,](#page-18-8) [45,](#page-18-9) [46,](#page-18-10) [47,](#page-18-11) [48\]](#page-18-12), and specific bug categories [\[48,](#page-18-12) [49,](#page-18-13) [50,](#page-18-14) [51,](#page-18-15) [52,](#page-18-16) [53\]](#page-18-17). Other works, instead, focused on devising new reduction strategies [\[54,](#page-18-18) [55,](#page-18-19) [56,](#page-18-20) [57,](#page-18-21) [58,](#page-19-0) [59\]](#page-19-1).

Papadakis et al. [\[33\]](#page-17-20) propose a checklist of best practices for using mutation testing in the context of controlled experiments for classical programs. Instead, we focus on quantum circuits and provide guidelines to select mutants for quantum circuits based on an extensive empirical evaluation.

Different works assessed the effectiveness of mutation operators for different artefacts, as we do in this work for mutation operators for quantum programs. Smith et al. [\[60\]](#page-19-2) conducted an empirical evaluation to assess the effectiveness of MuJava's mutation operators [\[61\]](#page-19-3) in software testing. The study categorized the behavior of mutants generated by selected mutation operators during successive attempts to detect them. The categorization used in the study includes the crossfire (subsumed mutants), dead on arrival (mutants detected by the initial test suite without any specific focus on mutation testing), Killed, and Stubborn (equivalent) mutants. This categorization provides a deeper understanding of the performance of individual operators and the behaviors exhibited by their resultant mutants. Our work studies the quantum mutation operators, and quantum mutants generated by them, across different quantum circuits. Our study presents a ranking for different mutants and their characteristics, providing valuable observations about their behavior and use.

Just et al. [\[62\]](#page-19-4) conducted a study to assess whether mutants can be an alternative to real faults. The study uses real faults from subject programs and compares the effectiveness of developer-written and automatically generated test suites in detecting these faults. The study investigated the correlation between real faults and mutants generated by commonly used mutation operators. It found that a statistically significant correlation exists for 73% of the real faults. The study also proposed improvements to the mutation analysis technique by introducing new or stronger mutation operators. They observed that 17% of faults were not coupled to any mutants, which reveals a fundamental limitation of mutation analysis, and the other 10% of actual faults required implementing new mutation operators. Even though our study does not directly relate to real faults, it is a substantial empirical study that can be used as a reference point for associating them with real quantum faults.

Zhang et al. [\[63\]](#page-19-5) explored how mutation analysis can be used for assessing the quality of use case models with use case specifications detailed in restricted natural language, with the ultimate goal of supporting requirements inspection. They proposed a taxonomy of defect types and defined nearly 200 mutation operators. A set of case studies demonstrated the feasibility of the proposed mutation analysis methodology. In contrast to this work, our study focuses on mutation analysis for quantum circuits.

Quantum Mutation Analysis. Two key mutation analysis tools are available, Muskit [\[16\]](#page-17-3) and QMutPy [\[5,](#page-16-4) [7,](#page-16-6) [8\]](#page-16-7). Both tools can generate mutated quantum circuits with mutation operators, e.g., related to adding, removing, or replacing quantum gates. Note that QMutPy provides additional mutation operators related to the measurement gates, Quantum Measurement Insertion, and Quantum Measurement Deletion. QMutPy further looks into bug patterns identified in [\[64\]](#page-19-6) and mutating a quantum gate with another "syntactically-equivalent" with the same number and types of arguments. Fortunato et al. point out that such equivalence helps reduce the total number of mutants and decreases the possibility of having equivalent mutants.

QMutPy and Muskit could generate many mutants, which might be infeasible to execute and even redundant. This paper instead studies the influence of various mutation characteristics, circuit characteristics, and algorithms and their classifications on the survivability of mutants via large-scale empirical evaluation to collect evidence to support researchers and practitioners in selecting meaningful mutants for mutation analysis. Moreover, based on the evidence collected, diverse mutant generation strategies can be developed and possibly integrated into QMutPy or Muskit.

Wang et al. [\[6\]](#page-16-5) proposed a mutation-based approach (*MutTG*) for generating the minimum number of test cases that maximizes the number of detected mutants to save the cost required to execute many test cases. *MutTG* also defines a metric to measure the difficulty of detecting a mutant based on the number of inputs that can detect the mutant out of the total number of inputs. The higher the number of inputs detecting the mutant, the easier it is to detect the mutant. Instead, we study the relationships between different circuit and mutant characteristics and quantum algorithms on the survivability of mutants with a large-scale empirical evaluation.

Quantum Software Bug Repositories. Recently, a few bug repositories have been published. The Bugs4Q benchmark suite [\[12\]](#page-16-11) collects bugs from the Qiskit GitHub repository, ensuring each bug has a buggy and a fixed version. They collected 36 bugs. In [\[14\]](#page-17-1), a proposal is presented for reproducible bugs in quantum software with a set of quantum programs, their corresponding bugs, and infrastructure to support experimentation. In [\[15\]](#page-17-2), a multi-lingual benchmark for property-based testing of quantum programs coded in Q# is proposed, consisting of a set of programs in Q# and corresponding properties. These works provide small-scale benchmarks and do not systematically analyze mutant characteristics, thereby giving no evidence about how easy it is to detect which mutants and which circuit characteristics make it difficult to detect a mutant. Thus, this paper presents a large-scale empirical evaluation to study how various mutant and circuit characteristics, algorithms, and their interactions affect detecting mutants.

Quantum software testing. The survey by García de la Barrera et al. [\[24\]](#page-17-11) shows an overview of the latest advancements in quantum software testing by systematically mapping the literature to evaluate its current state. The survey demonstrates an increasing trend in recent years to adapt classical testing techniques and develop new quantum software testing techniques. The study identifies three main trends in quantum software testing: using statistical methods on repeated executions to handle quantum stochasticity, adapting the Hoare logic [\[65\]](#page-19-7) for quantum software correctness, and using quantum circuit reversibility for information conservation. The study highlights that, despite the ongoing efforts to integrate test engineering practices into quantum computing, a need for established frameworks to integrate best practices and techniques remains.

Several quantum software testing techniques have been adapted from classical software testing. Moreover, new techniques specific to quantum software testing have been developed, contributing to the advancement of quantum software testing. For example, Honarvar et al. [\[4\]](#page-16-3) proposed a property-based testing approach that defines properties over input and output and uses these properties for test generation; Abreu et al. [\[66\]](#page-19-8) proposed a metamorphic testing approach in the context of quantum software; Wang et al. [\[10\]](#page-16-9), instead, proposed a combinatorial testing approach specifically designed for quantum software and investigated its effectiveness in detecting faults in quantum circuits. In contrast, our study provides valuable insights into the characteristics of quantum software mutants, which can serve as a foundation for assessing the efficacy and reliability of new or existing quantum software testing techniques.

Formal verification for quantum programs. Formal verification for quantum programs involves applying formal methods to check the correctness of quantum circuits. This new field of study tries to address the challenges introduced by the unique properties of quantum computers regarding new types of errors and the development of complex quantum algorithms. Unlike the empirical assessment employed by software testing, formal verification aims to provide a mathematical proof of correctness of software behavior. The survey by Lewis et al. [\[67\]](#page-19-9) provides some valuable insights about the current state of the field and tools developed, such as QWire [\[68\]](#page-19-10) and SQIR [\[69\]](#page-19-11). QWire emerged as one of the initial quantum programming languages for developing verifiable programs, whereas SQIR is a proof assistant for writing proofs about quantum programs. The survey highlights the importance of verification techniques that follow quantum software development, showing that verifiable programming languages need to be developed to be easy to learn or use.

Formal quantum verification methods provide proofs for quantum programs but require extensive quantum mechanics knowledge. Mutation analysis can be used to assess formal verification techniques by evaluating their ability to detect and handle mutations in system models or specifications as done for classical formal verification by Rao et al. [\[70\]](#page-19-12), and Jain et al. [\[71\]](#page-19-13). Our study provides more understanding of actual quantum mutation operators, which could potentially be useful to assess the effectiveness of formal verification methods for quantum programs in the future.

4 Experiment Design

We first define various characteristics in Section [4.1](#page-5-0) followed by research questions in Section [4.2.](#page-6-0) We describe metrics, subject systems, mutant generation, and experimental setup together with execution in Sections [4.3–](#page-6-1)[4.6,](#page-8-0) respectively.

Table 1: Algorithm Groups details

4.1 Characteristics of Mutations, Circuits, and Algorithms - Independent Variables

4.1.1 Mutation Characteristics

Mutation Operator Type (*Operator)*: We have three types of mutation operators, i.e., adding (*Add*), removing (*Remove*), or replacing (*Replace*) a quantum gate as described in Section [2.](#page-1-0) Quantum Gate Mutations: We study quantum gate characteristics from three perspectives. First, we study *mutated gates* (*Gate*) such as *Hadamard* and *CNOT* with a mutation operator (e.g., *Add*). In total, we have 19 gates that are currently implemented in Muskit [\[16\]](#page-17-3), which we used as a mutation framework. These gates are ccx, cswap, cx, cz, h, id, p, rx, rxx, ry, rz, rzz, s, swap, sx, t, x, y, and z. Interested readers may refer to the following reference for more details about each gate [\[72\]](#page-19-14). Second, we study *mutated gate types* (*Gate Type*) by classifying the implemented gates in Muskit into these seven categories representing the basic building blocks of Qiskit, i.e., Controlled gates (*Controlled*), Hadamard gates (*Hadamard*), Pauli gates (*Pauli*), Phase gates (*Phase*), Rotation gates (*Rotation*), Swap gates (*Swap*), and T gates (*T*). Third, we study *mutated gate size* (*Gate Size*), which classifies quantum gates into two categories: single-qubit (*Single*) and multi-qubit gates (*Multi*). This classification is common in quantum circuit design [\[72\]](#page-19-14). Note that these three independent variables (i.e., *Gate*, *Gate Type*, and *Gate Size*) are intertwined, which makes it very difficult to interpret their interaction effects. As a result, we do not study their interactions. Position (*Position*): We study the position in the circuit where a change is introduced as described in Section [2.](#page-1-0) Given that the total number of positions varies from one circuit to another, we use the *relative position* to the whole in terms of percentage, i.e., 10%, 20%, . . . , 100% to describe the position in the quantum circuit where a fault is seeded. For instance, 10% means the first 10% of the positions in a circuit.

4.1.2 Algorithms Characteristics

Algorithms: We study the effect of various algorithms (*Algorithm*) and their categorization from two aspects on the survivability of a faulty benchmark. We have 28 algorithms from MQT Bench, i.e., Quantum Program (QP) 1–28 as shown at the bottom of Table [2.](#page-8-1) More details about these algorithms can be found in [\[73\]](#page-19-15). Moreover, we use a classification from [\[73\]](#page-19-15) to classify the 28 algorithms into 12 categories and name this classification as *Algorithm Group*. These 12 categories are *ae*, *dj*, *ghz*, *graphstate*, *grover*, *qaoa*, *qft*, *qgan*, *qpe*, *qwalk*, *vqe*, and *wstate*. Such categories comprise the QPs that use the same *Algorithm* as a building block, i.e., derived from the same *Algorithm*. For example, in the case of the *ae Algorithm Group*, we consider the quantum programs based on *ae*: QP1, QP12, and QP13. QP1 consists of the original *ae* algorithm, and QP12 and QP13 are specific versions of the *ae* algorithm to satisfy a specific problem. QP12 uses the *ae* algorithm iteratively to estimate the fair price of a European call option, and QP13 uses the *ae* algorithm to estimate the fair price of a European put option. Some of the *Algorithms* are not used in other *Algorithms* as building blocks, meaning that some of the *Algorithm Group* consist only of one *Algorithm*. A brief explanation of each *Algorithm Group* together with the group *Algorithms* is shown in Table [1.](#page-5-1) An interested reader can consult [\[73\]](#page-19-15) for more details on it.

In addition, we classify all the algorithms into two categories according to their *Output Dominance*: (1) *output-dominant* algorithms that focus on finding the output with the highest probability, such as the case for optimization algorithms. For such algorithms, we check if the produced dominant output matches the expected one. In total, we have 19 output-dominant algorithms; (2) *diverse-output* algorithms with many outputs of different probabilities. As a result, to check the correctness of diverse-output algorithms, we need to compare all possible outputs and their probabilities with the expected ones. In total, we have nine of these algorithms.

4.1.3 Circuit Characteristics

Circuit Complexity: We study the typical metrics used to measure the complexity of circuits, i.e., the *number of qubits* (*#qubits*), the *total number of quantum gates* (*#gates*), and the *number of measurements* (*#measurements*), counting the numbers of qubits, gates, and measurements in a circuit [\[74,](#page-19-16) [75\]](#page-19-17). In addition, we use circuit depth $(depth)$, a commonly used metric, to measure the complexity of a quantum circuit, which is defined as the length of the longest path (measured as the number of gates) of the circuit from its beginning to the end [\[76\]](#page-19-18). Gate Complexity. To assess the effect of gate complexity on survivability, we study three characteristics, i.e., the number of single-qubit gates (*#singleGates*), the number of multi-qubit gates (*#multiGates*), and the number of entangled qubits (*#eQubits*). We count the number of entangled qubits in a circuit by checking all its interaction states in the circuit and the qubits they relate to.

4.2 Research Questions

- RQ1: How do the various quantum mutation characteristics influence the survivability of faulty benchmarks? This RQ is further divided into three sub-research questions:
	- *RQ1.1* How does each of the characteristics individually affect the survivability of faulty benchmarks?
	- *RQ1.2* How does each of the pair-wise combinations between characteristics affect the survivability of faulty benchmarks?
	- *RQ1.3* How do the interactions among all the characteristics affect the survivability of faulty benchmarks?
	- In RQ1, we study the main mutation characteristics (Section [4.1.1\)](#page-5-2) and their interactions.
- RQ2: How does a quantum algorithm or quantum algorithm type affect the survivability of faulty benchmarks? RQ2 studies individual algorithms and the effect of their two types of outputs (Section [4.1.2\)](#page-5-3) on the survivability of faulty benchmarks:
	- *RQ2.1* How does the *output dominance* affect the survivability of faulty benchmarks?
	- *RQ2.2* How does each *algorithm group* affect the survivability of faulty benchmarks?
	- *RQ2.3* How does each *algorithm* affect the survivability of faulty benchmarks?
- RQ3: How do the characteristics of a quantum circuit affect the survivability of its faulty benchmarks? In particular, we study the influence of circuit and gate complexity on survivability (Section [4.1.3\)](#page-6-2).
- RQ4: How do the interactions of the algorithm characteristics with the mutation characteristics influence the survivability of faulty benchmarks? This RQ is further divided into three sub-research questions:
	- *RQ4.1* How does the interaction between the *algorithm* and mutation characteristics influence the survivability of faulty benchmarks?
	- *RQ4.2* How does the interaction between the *algorithm group* and mutation characteristics influence the survivability of faulty benchmarks?
	- *RQ4.3* How does the interaction between the *output dominance* and mutation characteristics influence the survivability of faulty benchmarks?

Note that we also studied interactions with more than one mutation characteristic. However, given many possible combinations, they are only considered when automatically generating recommendations (Section [5.5\)](#page-15-0). Nonetheless, all interaction data is available in our repository [\[17\]](#page-17-4).

4.3 Metrics and Statistical Tests

To quantify the effect of the mutation and circuit characteristics, algorithms and their classifications, and interactions (i.e., captured as independent variables) on the survivability of faulty benchmarks (the dependent variable), we define the metric *Survival Rate* (SR). The *survival rate* refers to the percentage of survived mutants (i.e., calculated based on undetected) obtained for a particular independent variable. This is the opposite of the typically used metric *mutation score*, which is calculated based on the percentage of detected mutants. We decided to use the SR since we wanted to study the characteristics of mutants that are

hard to detect; therefore, we chose a metric that focuses on mutants that are not detected. The metric is calculated by dividing the number of survived mutants by the total number of mutants, corresponding to each independent variable as:

$$
SR_{IV} = \frac{totalSurvivors_{IV}}{totalMutants_{IV}}
$$

IV represents a set of independent variables corresponding to each mutant, algorithm, circuit characteristics, and interactions, e.g., *Gate. totalSurvivors_{IV}* represents the total number of survived mutants for a particular independent variable, e.g., for *Gate* independent variable, an example is h gate. $totalMutants_{IV}$ represents the total number of mutants for a particular independent variable (e.g., *h* for *Gate*).

In this study, we executed each mutant with its default program setting without introducing any specific input, i.e., all qubits initialized to 0. To determine the survival of a mutant, we check if a mutant is detected by the Wrong Output Oracle (WOO) and Output Probability Oracle (OPO) as was previously done in the literature [\[16,](#page-17-3) [3,](#page-16-2) [31\]](#page-17-18):

- 1. *Wrong Output Oracle (WOO)*: The observed output does not match the expected output of the program, i.e., a new output is observed. As described in Section [4.1.2,](#page-5-3) we have two broad categories of algorithms for *Output Dominance*. For *Output-dominant* algorithms, which are expected to produce one dominant output, if the dominant output produced by an algorithm does not match the expected dominant output, we consider it a detected mutant. For the rest of the algorithms (i.e., *Diverse-output*), if any of the observed outputs do not match the expected outputs, we consider it as a detected mutant.
- 2. *Output Probability Oracle (OPO)*: The observed outputs match with the expected ones; however, the observed probabilities are significantly different than the expected ones. To compare the expected probabilities with observed probabilities, OPO employs the Chi-square test. We chose a significance level of 0.01, i.e., if the p-value is less than 0.01, we conclude that a mutant is detected. Note that, since in *Output-dominant* algorithms we only care about the dominant output, i.e., the output with the highest probability, we only consider this oracle for *Diverse-Output* algorithms. In *Output-dominant* algorithms, if the observed dominant output remains the same as the expected dominant output, even if the probability of the output has changed, the mutant will not be considered detected.

RQ3 studies the relations between circuit characteristics (e.g., *#qubits*) and SR. RQ3 also studies the correlation between an independent variable and SR with the Pearson correlation test [\[77\]](#page-19-19). Pearson coefficient ranges between -1 and 1, where a value below (or above) 0 indicates a negative (or positive) correlation.

4.4 Subject Systems

In our empirical study, we used a set of real quantum circuits provided by MQT Bench [\[73\]](#page-19-15). In total, MQT Bench offers more than 70,000 circuits with different configuration settings. We used the selection criteria provided by MQT Bench to obtain the circuits. The MQT Bench provides two types of circuits: Non-scalable circuits with fixed numbers of qubits and scalable ones, i.e., the same circuits implemented with different numbers of qubits. For scalable benchmarks, we configured the range of the number of qubits from 2 to 30. The maximum number of 30 was chosen because this is the maximum number of qubits we could simulate on a classical computer with the IBM simulator for most algorithms. Setting the maximum qubits to 30 for some circuits resulted in a complex circuit with many quantum gates that became infeasible to execute on quantum simulators. Consequently, we reduced the number of qubits for such algorithms according to this practical constraint. Since the study was performed in the Qiskit simulator, we selected the Qiskit compiler option at the target-independent level. The obtained benchmark consists of 382 circuits (21 non-scalable and 361 scalable ones), which are implemented in Open Quantum Assembly Language (QASM) V.2 [\[78\]](#page-19-20) as the original benchmarks. We further automatically translated them to Qiskit to be compatible with Muskit, which currently can only generate mutants for Qiskit. Table [2](#page-8-1) shows the characteristics of the original benchmarks for each quantum algorithm.

4.5 Mutant Generation

We use the Muskit tool [\[16\]](#page-17-3) to generate faulty benchmarks by applying *Add*, *Remove*, and *Replace* mutation operators. To be comprehensive, for this empirical study, we applied all mutation operators combined with a total of 19 available gate types, on all possible positions, in each original quantum circuit for each quantum algorithm. The *Add* operation is applied in all the possible positions using all supported gates, the *Replace* operation replaces an existing gate with a new supported gate, and the *Remove* operation will just remove an existing gate.

In the end, we obtained 723,079 faulty benchmarks, most of which were created with the *Add* operator (75%), followed by *Replace* (20%) and *Remove* (3%). Note that, as mentioned above, the *Replace* and *Remove* operators can only be applied on existing gates of the original quantum circuits, while the *Add* operator can be applied anywhere in the circuit; therefore, compared

Table 2: Characteristics of the original benchmarks (i.e., quantum algorithm). ID represents the unique identifier of a

*QP1: Amplitude Estimation (ae); QP2: Deutsch-Jozsa (dj); QP3: Greenberger-Horne-Zeilinger State (ghz); QP4: Graph State (graphstate); QP5: Ground State (groundstatelarge); QP6: Ground State (groundstatemedium); QP7: Ground State (groundstatesmall); QP8: Grover Search without Ancilla (grover-noancilla); QP9: Grover Search with Ancilla (grover-v-chain); QP10: Portfolio Optimization with QAOA (portfolioqaoa); QP11: Porfolio Optimization with VQE (portfoliovqe); QP12: Pricing Call Option (pricingcall); QP13: Pricing Put Option (pricingput); QP14: Quantum Approximate Optimization Algorithm (qaoa); QP15: Quantum Fourier Transform (qft); QP16: Quantun Fourier Transform Entangled (qftentangled); QP17: Quantum Generative Adversarial Networks (qgan); QP18: Quantum Phase Estimation Exact (qpeexact); QP19: Quantum Phase Estimation Inexact (qpeinexact); QP20: Quantum Walk without Ancilla (qwalk-noancilla); QP21: Quantum Walk with Ancilla (qwalk-v-chain); QP22: Real Amplitudes ansatz with Random Parameters

(realamprandom); QP23: Routing Algorithm (routing); QP24: Efficient SU2 ansatz with Random Parameters (su2random); QP25: Travelling Salesman (tsp); QP26: Two Local ansatz with random parameters (twolocalrandom); QP27: Variational Quantum Eigensolver (vqe); QP28: W-State (wstate).

Figure 2: Descriptive statistics of the generated benchmarks

with *Add*, we obtained fewer numbers of faulty benchmarks created with them. We calculate the SR for each independent variable; note that, in this way, each operator is treated equally, as the number of its occurrences can not bias the results. Figure [2](#page-8-2) presents the descriptive statistics of the generated benchmarks.

4.6 Experimental Setup and Execution

All the original and faulty benchmarks were executed under the same conditions using the same computational resources. The experiments run on a national high-performance cluster of servers, including 2x AMD Epyc 7601 processors, 2TB RAM, an AMD Vega20 GPU, and a high-speed 4TB NVMe drive. We performed a total of 100,000 shots for each circuit to deal with the inherent uncertainty in quantum computing. All the programs were executed using the Qiskit 0.43.1 version's Aer simulator to execute quantum circuits. To ensure consistency and reproducibility, we employed a fixed random seed, a key parameter of the Aer simulator for executing all quantum circuits, to deal with the inherent uncertainty of the quantum circuit execution.

Which quantum circuit mutants shall be used?

5 Results and Analysis

We present empirical evaluation results. For the 382 circuits corresponding to the 28 algorithms, we generated a total of 723079 faulty benchmarks. After executing them, we obtained the overall SR of 48%, against the 51% that were detected with test oracle WOO, and 1% detected with test oracle OPO.

5.1 Results for RQ1 - Analyzing SR by Mutation Characteristics

5.1.1 Results for RQ1.1 (individual characteristics)

Figure 3: Average SR of all faulty benchmarks in terms of each mutation characteristic - RQ1.1

Figure [3](#page-9-1) presents the SR's descriptive statistics in each characteristic across all the faulty benchmarks. For *Operator*, we observe that mutation operator *Add* achieved higher SR (see Figure [3\)](#page-9-1) than *Remove* and *Replace*. This observation provides evidence that the *Add* operator is more likely to generate faulty benchmarks with high chances of surviving, which is often wanted for assessing testing methods. For *Position*, we can notice that manipulating faults at the beginning and end of a quantum circuit (100%, 90%, 10%, and 20%) achieved the top four SR (around 50% and above) among the ten categories. As for *Gate Size*, whether being added, deleted, and replaced gate via a mutation operator is a single-qubit gate or multi-qubit gate does not lead to a big difference in SR, i.e., 45.5% and 52.2%, respectively. Regarding characteristic *Gate*, we note that gate *Id* achieved the highest SR. This is expected as *Id* is a single-qubit gate that does not change the qubit's state. It is often used for error correction, fault tolerance, or as a placeholder for maintaining the same circuit depth. However, surprisingly the *id* gate did not achieve a 100%. Our investigation found that the remaining mutants that were detected easily were for *Graphstate* (QP4). This algorithm produces all possible outputs with certain probabilities. Given our chosen number of shots (i.e., 100,000), we could not ensure covering all outputs for its implementation with more than 16 qubits, and therefore, we obtained false positives.

On the other hand, gates *x*, *y*, and *h* achieved the lowest SR since these gates introduce big changes in circuit logic, i.e., *h* introduces superposition, whereas x flips the state of a qubit (i.e., $|1\rangle$ to $|0\rangle$ and vice versa) and y in addition to state flip, also rotates the phase about the Y axis by π radians. As a result, survival rates were the lowest.

When looking at *Gate Type*, we notice that the *T* gates, *Phase* gates, and *Controlled* gates achieved the top three SR. On the other hand, the *Hadamard* gate achieved the lowest SR. This is because the Hadamard creates superposition, and manipulating a fault with Hadamard changes the logic of a quantum circuit, thereby detecting the fault more easily compared with the other gates.

5.1.2 Results for RQ1.2 (pair-wise interactions)

Figure [4](#page-10-0) shows the effect of the interactions between *Position* and each circuit characteristic (e.g., *Gate*, *Gate Size*). Overall, most of the characteristics follow the same pattern mentioned above, faults applied at the beginning or end of a quantum circuit achieve a higher SR than the ones applied in the middle. Such a pattern can be observed clearly in *Phase* gates or *T* gates. However, not all the gates follow the same pattern, in the case of the *Hadamard* gate, it starts with a higher SR at the beginning of the circuit and reaches the lowest SR at the end. In addition, the susceptibility of the different *Gates* with respect to the *Position* can be deduced, for instance, the interaction effect between *Position* and gates *x* and *y* is very low, meaning that such gates are less susceptible to the *Position* where they are applied.

Figure 4: Interaction effects between *Position* and all other mutation characteristics - RQ1.2. Each cell shows the SR corresponding to a specific interaction, with a darker (or lighter) blue indicating a higher (or lower) SR.

Figure 5: Interaction effects between *Operator* and all other mutation characteristics - RQ1.2. Each cell shows SR corresponding to a specific interaction. A darker (or lighter) blue indicates a higher (or lower) SR; a white empty cell denotes an absolute zero SR; a cell with zero in it denotes a very-near-zero positive number; a cell with X tells that no benchmarks can be generated with the given combination.

Figure [5](#page-10-1) presents the interaction effects of *Operator* with all other characteristics. Note that in some cases (denoted with \times in cells), the combinations (e.g., removing a T gate, replacing an id gate) are impossible for given quantum circuits since the original circuits do not contain these gates. Therefore, no corresponding faulty benchmarks were generated. From the figure, we can observe that, in most cases, the *Add* operator is prominent in leading to high SR, as we have also discussed in RQ1.1. However, there are some exceptions. For instance, adding, removing, and replacing the rotation gates do not differ significantly.

5.1.3 Results for RQ1.3 (interactions among all characteristics)

To illustrate the categories' interaction effects, in Table [3,](#page-10-2) we report the top five cases that achieved the highest SR. However, all

Table 3: Top 5 interactions of mutation characteristics *Operator*, *Gate* (or *Gate Type*, *Gate Size*) and *Position* that achieved the highest SR, e.g., Add_id_80.0{1.0}: adding an *id* gate at position 80% achieved 100% SR- RQ1.3.

the results are available in the online repository [\[17\]](#page-17-4). When looking at the first row of the table, one can observe that adding *id*

gate at positions 80%, 90%, 100%, 70%, and 10% achieved the top five SR (ranging from 100% to 97%). Regarding the effect of the interactions among *Operator*, *Gate Type* and *Position*, we can observe, from the second row of the table, that adding a *Phase* or *T* gate at the end or beginning positions achieved the top five SR. Regarding the interaction effects of the combination of *Operator*, *Gate Size* and *Position*, from the results of our study, we recommend adding a multi-gate at position 100% to generate faulty benchmarks that are most challenging, i.e., the highest SR.

Concluding Remarks for RQ1: Applying operator *Add* led to slightly higher SR than *Remove* and *Replace*. Introducing faults at the beginning or end of a quantum circuit has a higher chance of generating faulty benchmarks that can survive testing. Gates *y*, *x* and *h* achieved the lowest SR, while *T* and *Phase* achieved the highest SR.

5.2 Results for RQ2 - Analyzing SR by Algorithms and their Categorization

5.2.1 Results for RQ2.1 (Output Dominance)

When comparing algorithms regarding the type of output (i.e., *output-dominant* algorithms and *diverse-output* algorithms), we observe that the *output-dominant* algorithms have relatively higher SR (i.e., 53.5%) than the others (i.e., 34.7%), as shown in Figure [6.](#page-11-0) This tells that faulty benchmarks of the *output-dominant* algorithms are easier to survive. Recall from Section [4.3](#page-6-1) that,

Figure 6: Average SR of all faulty benchmarks regarding algorithms - RQ2. Dark and light blues differentiate outputdominant and diverse-output algorithms.

to check whether a faulty benchmark of an *output-dominant* algorithm is survived, we assess the WOO oracle, i.e., checking whether the observed dominant output is the same as the expected. Therefore, if a faulty benchmark of *output-dominant* algorithm does not change the expected dominant output, the assessment of WOO remains the same, meaning that the mutation cannot affect the dominant output, i.e., the benchmark survived.

5.2.2 Results for RQ2.2 (Algorithm Group)

When looking into the 12 algorithm groups (see Figure [6\)](#page-11-0), the faulty benchmarks generated for *qpe* and *vqe* achieved the highest SR: 63% and 56.8%, respectively, indicating that they are more tolerant to seeded faults. On the lowest side, *qgan*, *wstate*, and *graphstate* obtained the lowest SR: 13.4%, 27.5% and 28.6%, respectively, indicating that the faulty benchmarks generated from these groups are difficult to survive. As already observed in RQ2.1, in general, *output-dominant* algorithms tend to have higher SR. However, *qft* and *ghz* algorithms are exceptions, as they achieved higher SR than three other *output-dominant* algorithms. For *ghz*, one plausible explanation is that the *ghz* algorithms entangle all qubits in a circuit, and once they are entangled, any mutation operator applied to one qubit will affect the state of all others; when they are measured, they will be all in the same basis state (i.e., all 0 or all 1). This logic seems to reduce the chance of producing incorrect outcomes even when faults are seeded, leading to high SR. As for the *qft* algorithms, they are typically implemented with *CP* and *H* gates. However, *CP* is not

one of the gates that the three mutation operators can manipulate, as Muskit currently does not support it. Therefore, no cases exist for removing or replacing *CP* gates in the generated benchmarks for *qft*. Furthermore, as we already observed in RQ1.1, applying *Remove* and *Replace* led to lower SR, as compared to *Add*. Therefore, relying on adding gates probably led to the high SR. However, we need additional experiments to understand *qft* and *ghz* better.

5.2.3 Results for RQ2.3 (individual algorithm, i.e., Algorithm)

For each algorithm, we observe a similar pattern as in RQ2.2, where *output-dominant* algorithms tend to have higher SR. The exceptions are the two *diverse-output* algorithms: QP15 - *qft* (belonging to the *qft* algorithm group) and QP3 - *ghz* (the only algorithm in the *ghz* algorithm group), for which generated faulty benchmarks exhibited higher SR than some of the output-dominant algorithms. Note that we have explained the possible reason in RQ2.2.

When looking at the lowest SR, QP5 - *groundstatemedium* and QP6 –*groundstatelarge* and QP17 - *qgan* obtained the lowest SR: 11.9%, 12.3%, and 13.4% respectively. Interestingly, QP5 and QP6, even belonging to the *output-dominant* algorithm category, still have the lowest SRs. One possible reason is that these two algorithms have a larger number of qubits as compared with QP7 - *groundstatesmall* (Table [2\)](#page-8-1), which all share the same overall structure. This explains that QP5 and QP6 have more possible outputs than QP7; consequently, the dominant output of both is less prominent and, therefore, more sensitive to faults. As for *qgan*, among the *diverse-output* algorithms, it has the lowest SR. This might be because *qgan* has two key components: generator and discriminator. Any changes to the generator may influence the discriminator's behavior and vice versa, leading to a change that is propagated incrementally. Hence, *qgan* is more sensitive to changes and therefore obtains low SR.

Concluding Remarks for RQ2: Typically, the *dominant-output* algorithms have higher survival rates except for ground state algorithms. For *diverse-output*, in general, we observed low survival rates except for *ghz* and *qft*.

5.3 Results for RQ3 - Analyzing SR by Circuit Characteristics

We studied the relationship between circuit characteristics on the survivability of faulty benchmarks, i.e., the correlation between an independent variable (e.g., number of qubits *#qubits*) and its corresponding SR with the Pearson correlation test. Results show that all correlation coefficients are between -0.1 and 0.1 for all circuit characteristics, indicating no correlation. This is expected as these characteristics, though they are important metrics for measuring the complexity of circuits, do not fully describe their computational logic, such as how qubits are entangled.

Concluding Remarks for RQ3: No significant correlations can be observed between the circuit characteristics and the survivability of faulty benchmarks.

5.4 Results for RQ4 - Interactions between Algorithm and Mutation Characteristics

All results for RQ4 are presented in Figure [7.](#page-13-0)

5.4.1 Results for RQ4.1 - Interactions with Algorithm

When looking at the interactions of each algorithm with each mutation characteristic, one can notice that for most algorithms, applying the *Add* operator led to the highest SR, as we already observed in RQ1. However, for certain algorithms (e.g., QP26–*twolocalrandom*, QP24–*su2random*, QP22–*realamprandom*, which all belong to *vqe*), the *Remove* operator led to the highest SR, implying that removing a gate from these algorithms has the least impact on their outcomes.

Regarding the interaction of *Algorithm* and *Gate Size*, we observe that, in 15 out of 28 cases, manipulating multi-qubit gates achieves higher SR than manipulating single-qubit gates, supporting the conclusions obtained in RQ1.1. For instance, for QP4–*graphstate*, manipulating multi-qubit gates led to 46% SR, which is notably higher than what manipulating single-qubit achieved: 19%. When looking at the interaction of *Algorithm* and *Gate Type*, manipulating a *Hadamard* gate led to the least SR for most algorithms. However, there are a few exceptions. For instance, for QP18 - *qpeexact*, manipulating a *Hadamard* gate achieved 84% SR, i.e., higher than manipulating a *Pauli*, *Rotation*, or *Swap* gate. One plausible explanation is that the algorithm only has one dominant output, and therefore introducing a fault by manipulating a *Hadamard* gate has a chance of changing the output probabilities but not necessarily altering the dominant output. Manipulating a *T* gate led to the highest SR with a few exceptions, such as QP4 - *graphstate*, for which manipulating a *Swap* gate achieved the highest SR (i.e., 98%). This is because this algorithm produces all possible outputs, so swapping the qubits does not have much effect, as the same state will be reached in another shot.

QP1: ae; QP2: dj; QP3: ghz; QP4: graphstate; QP5: groundstatelarge; QP6: groundstatemedium; QP7: groundstatesmall; QP8: grover-noancilla; QP9: grover-v-chain; QP10: portfolioqaoa; QP11: portfoliovqe;
QP12: pricingcall; QP1

Figure 7: Interaction effects between *Algorithm* (or *Algorithm Group*, *Dominant*) and all mutation characteristics - RQ4. A darker (or lighter) blue indicates a higher (or lower) SR; a white empty cell denotes an absolute zero SR; a cell with zero in it denotes a very-near-zero positive number; a cell with X tells that no benchmarks can be generated with the given combination.

Which quantum circuit mutants shall be used?

Regarding specific gates, as discussed in RQ1, *id* led to the 100% SR, with two exceptions on QP9 - *grover-v-chain* and QP4 *graphstate*. For QP9, after checking the data, we noted that only the two-qubit circuit was affected by *id* because switching the dominant output from one to the other is easy due to similar probabilities. As for QP4 - *graphstate*, as discussed in RQ1.1, it produces all possible outputs, and with the given number of shots, we could not cover all possible outputs.

When comparing Pauli gates (*X*, *Y*, and *Z*), *Z* achieved the highest SR for most cases. This might be because *Z* does not change the probabilities of outputs. For QP5 - *groundstatelarge* and QP6 - *groundstatemedium*, the differences in SR across the different gates excluding *id* are very small. We note that for QP15 - *qft*, 14 out of 19 gates achieved 100% SR, implying that the faulty benchmarks for *qft* are very difficult to detect, as already discussed in RQ2.2.

When checking *Position*, we note that introducing faults to the beginning and end of the circuits of most algorithms led to high SR with some exceptions (e.g., QP17, QP18, QP4). For instance, for QP4 - *graphstate*, the SR at position 10% is only 0.15, implying that introducing a fault at the beginning of the circuit of the *graphstate* algorithm is possible to change its behavior.

5.4.2 Results for RQ4.2 (Interaction with Algorithm Group)

Figure [7](#page-13-0) shows that the *vqe* and *graphstate* algorithms achieved the highest SR when the *Remove* operator is applied. For *vqe*, removing a gate only changes the probability of a dominant output. In *vqe*, we only care about the correct dominant output, and as long as the correct output remains dominant, it is considered survived.

Regarding *Gate Size*, we only observe a difference in terms of SR between manipulating single-qubit gates and multi-qubit gates for *grover* (40% vs 27%) and *graphstate* (19% vs 46%). As we saw in Section [5.1,](#page-9-2) multi-qubit, overall, had a higher SR than single-qubit, with which the behavior of *graphstate* conforms. However, for *grover*, it is reversed. A possible reason is that *grover* has many multi-qubit gates (Table [2\)](#page-8-1); therefore, removing or replacing multi-qubit gates has a high chance of changing the logic of the circuits, which, hence, led to lower SR than manipulating single-qubit gates.

Manipulating *Hadamard* (resp. *T*) achieved the lowest (resp. highest) SR for most algorithm types, as also discussed in RQ1. We further observe that SR of *vqe* and *qpe* are higher than those of other algorithms across the different gate types (also discussed in RQ2.2).

For each individual gate, we observe differences in the SR among the same gate types. For instance, for the *ghz* algorithms, manipulating *cz* has a much higher chance of making the faulty *ghz* benchmarks survive when compared with *cx*, i.e., 100% vs 1% SR. This is reasonable because a *cz* gate induces a phase flip, which might not affect the final measurement results, but a *cx* gate introduces both bit and phase flips. When comparing the three Pauli gates $(x, y, \text{ and } z)$, we observe that manipulating a z gate led to much higher SR across the algorithm groups. Similarly, this might be because *z* gates do not change the probabilities of outputs.

Regarding *Position*, the *vqe* and *qpe* algorithms are less sensitive to the positions where the faults are seeded. This is because initializing the *vqe* and *qpe* algorithms is not only about applying the Hadamard gate to all qubits. Specifically, a parameterized trial state should be created for a *vqe* algorithm as part of the initialization, and an eigenstate should be prepared for *qpe*. Therefore, they both do not show the pattern we observed about *Position*: seeding a fault at the beginning or end of a circuit is easy to survive (RQ1.2).

5.4.3 Results for RQ4.3 - Interaction with Output Dominance

As expected, results for the *output-dominant* algorithms and *diverse-output* algorithms are quite different. First, for *outputdominant* algorithms (e.g., *qpe*), our results do not reveal much difference in terms of the mutation operators (55% vs 55% vs 48% for *Add*, *Remove* and *Replace*, respectively). Also, the SR of these algorithms' faulty benchmarks is generally higher than the *diverse-output* algorithms. This is reasonable because *output-dominant* algorithms are generally more robust or fault-tolerant of faults, as their working mechanisms amplify the probability of the correct answer (i.e., dominant output). Even with small errors, the correct answer can still be the most likely outcome. Due to this reason, we think manipulating *Hadamard* gates in the *output-dominant* algorithms led to comparable SR as manipulating *Pauli* and *Rotation* gates, and they are not sensitive to where a fault is seeded. This is, however, not the case for *diverse-output* algorithms.

Concluding Remarks for RQ4: The interactions of *Algorithm*, *Algorithm Group*, and *Output Dominance* with the mutation characteristics conform to what we observed in RQ1 and RQ2 with a few exceptions, mostly caused by individual algorithms' unique characteristics. We also observed the importance of distinguishing *output-dominant* and *diverse-output* algorithms in terms of where to seed a fault and which mutation operator to apply.

5.5 Discussion and Recommendations

Availability of Dataset and Recommendation Tool. The database from our empirical evaluation is available for anyone interested in using them.^{[1](#page-15-1)}. On top of the faulty benchmarks, we also built a software tool^{[2](#page-15-2)}, which can recommend faulty benchmarks to users based on selection criteria. For instance, a user can specify an *Algorithm*, *Algorithm Group*, or algorithms by *Output Dominance* together with desired SR and a maximum number of faulty benchmarks, and the software tool can provide the faulty benchmarks. This recommendation tool was built by studying all the possible interactions between *Algorithm*, *Algorithm Group*, or algorithms by *Output Dominance* with all possible mutation characteristics (i.e., single, pair-wise, and three-ways).

Assessing Quantum Software Testing Techniques. One typical use of faulty benchmarks is to assess the cost-effectiveness of quantum software testing techniques from various perspectives. For instance, users can assess whether their testing techniques can detect faults seeded in faulty benchmarks of varying survival rates. Moreover, one could also assess whether their testing techniques can identify faults seeded with specific mutation characteristics (e.g., the position of a fault).

Generating New Faulty Benchmarks. We generate new knowledge about relationships between the SR of faulty benchmarks and characteristics of mutations, circuits, algorithms, and their interactions. This knowledge provides evidence about faulty benchmarks with which characteristics likely survive, based on which one can generate new faulty benchmarks for new quantum algorithms, algorithms not yet studied in our empirical study.

Building New Mutation Analysis Techniques. Based on the new knowledge generated from our empirical evaluation, one can develop more advanced quantum mutation analysis techniques. Some examples include developing an optimization approach (e.g., based on search algorithms) to minimize the number of faulty benchmarks to select based on similar survival rates and characteristics.

Evolution of the findings. Given that quantum software engineering is in its preliminary stage, one could argue that the mutants used in this study are too circuit-specific to be used in the future. Our empirical evaluation focuses on studying the current state of quantum mutants and their characteristics. In the following years, more quantum gates and circuit-based approaches may arise, leading to the development of new quantum circuits. As a result, our empirical study needs to be re-executed and updated as the field evolves, resulting in new knowledge and insights about quantum mutation analysis.

5.6 Threats to validity

A typical threat to the validity is about the generalization of our results. Note that we pick the real quantum algorithms from the most comprehensive circuit benchmark repository (i.e., MQT Bench). We generated more than 700K mutants from them, thus, making it the largest study on studying quantum mutation characteristics. Nonetheless, one could further enlarge the empirical evaluation with more circuits, which we will pursue in the future.

Concerning the maximum number of qubits, we used a maximum of 30 qubit programs, and the results may be different for circuits with a higher number of qubits. However, it is impossible to execute large qubit circuits on classical computers. Moreover, one could also ask if our results are replicable on real quantum computers since we executed the circuits on the ideal simulator on classical computers. We argue that performing the study on the ideal simulator is important in our context since running experiments on real quantum computers would impact the results due to noise and could potentially lead to invalid conclusions. Nonetheless, we need a dedicated empirical evaluation on noisy quantum computers.

We set the number of shots to 100K, which may be insufficient for large circuits producing all possible outputs. However, most of our algorithms produce dominant outputs; therefore, 100K shots are sufficient. For the OPO test oracle, we chose a significance level of 0.01. Using a lower threshold (e.g., 0.001) may lead to detecting more mutants, thereby decreasing SR. However, 0.01 is commonly used and is a reasonable choice [\[79,](#page-19-21) [80,](#page-20-0) [10\]](#page-16-9). In the WOO oracle for the *output-dominant* algorithms, we only checked whether the observed dominant output matches the expected one. This could impact survivability. However, there are not many research results on how to check the correctness of *output-dominant* algorithms, thereby requiring more research on test oracles for such algorithms.

One of the main concerns in mutation analysis is the presence of equivalent and redundant mutants. In this study, we did not explicitly address the issue arising from such mutants, which could influence the conclusions drawn. Given the probabilistic nature of quantum programs and the difficulty in verifying similarity in quantum outputs, assessing the equivalence of mutants becomes particularly challenging. More research in this direction is needed to understand better and mitigate the impact of such mutants on mutation analysis, which is one of our future works.

When considering the abstraction level and how the mutations are introduced in classical mutation analysis, several pieces of evidence show the relationship between mutants and real faults [\[81\]](#page-20-1). However, in quantum mutation analysis, even though there

¹ Faulty benchmarks can be downloaded from our GitHub repository during the review. If the paper is accepted, we will publish it on a dedicated web page.

²Note that the software tool is also available in the GitHub repository.

are existing benchmarks for faults, linking syntactically introduced faults to developer faults remains challenging. Zhao et al., in Bugs4Q [\[12,](#page-16-11) [13\]](#page-17-0), offer a bug classification that shows circuit-level faults as a viable approach. In the future, additional research will be conducted to keep the study up-to-date by incorporating new mutation operators into empirical evaluation corresponding to new real faults.

6 Conclusions and Future Work

We presented an empirical study with more than 0.7 million quantum circuit mutants to study how various mutation characteristics, circuit characteristics, algorithm types, and their interactions relate to mutants being undetected (called survivability). Such a study helps to systematically design and generate faulty benchmarks for evaluating quantum software testing techniques' effectiveness from various aspects, e.g., the capability of detecting various types and complexity of faults. Based on the results, we provide actionable recommendations for researchers and practitioners to generate faulty benchmarks. Moreover, we will extend our empirical evaluations with even larger circuits, possibly executing them on real quantum computers, and continuously update the recommendations and the tool as this research area evolves. In addition, we plan to extend our empirical evaluation to include the detection of equivalent and redundant mutants.

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References

- [1] M. Coccia, S. Roshani, and M. Mosleh, "Evolution of quantum computing: Theoretical and innovation management implications for emerging quantum industry," *IEEE Transactions on Engineering Management*, pp. 1–11, 2022.
- [2] S. Ali, T. Yue, and R. Abreu, "When software engineering meets quantum computing," *Commun. ACM*, vol. 65, no. 4, pp. 84–88, 3 2022.
- [3] S. Ali, P. Arcaini, X. Wang, and T. Yue, "Assessing the effectiveness of input and output coverage criteria for testing quantum programs," in *2021 14th IEEE Conference on Software Testing, Verification and Validation (ICST)*, 2021, pp. 13–23.
- [4] S. Honarvar, M. R. Mousavi, and R. Nagarajan, "Property-based testing of quantum programs in Q#," in *Proceedings of the IEEE/ACM 42nd International Conference on Software Engineering Workshops*, ser. ICSEW'20. New York, NY, USA: Association for Computing Machinery, 2020, pp. 430–435.
- [5] D. Fortunato, J. Campos, and R. Abreu, "QMutPy: A mutation testing tool for quantum algorithms and applications in qiskit," in *Proceedings of the 31st ACM SIGSOFT International Symposium on Software Testing and Analysis*, ser. ISSTA 2022. New York, NY, USA: Association for Computing Machinery, 2022, pp. 797–800.
- [6] X. Wang, T. Yu, P. Arcaini, T. Yue, and S. Ali, "Mutation-based test generation for quantum programs with multi-objective search," in *Proceedings of the Genetic and Evolutionary Computation Conference*, ser. GECCO '22. New York, NY, USA: Association for Computing Machinery, 2022, pp. 1345–1353.
- [7] D. Fortunato, J. Campos, and R. Abreu, "Mutation testing of quantum programs written in QISKit," in *Proceedings of the ACM/IEEE 44th International Conference on Software Engineering: Companion Proceedings*, ser. ICSE '22. New York, NY, USA: Association for Computing Machinery, 2022, pp. 358–359.
- [8] ——, "Mutation testing of quantum programs: A case study with Qiskit," *IEEE Transactions on Quantum Engineering*, vol. 3, pp. 1–17, 2022.
- [9] X. Wang, P. Arcaini, T. Yue, and S. Ali, "Generating failing test suites for quantum programs with search," in *Search-Based Software Engineering*. Cham: Springer International Publishing, 2021, pp. 9–25.
- [10] ——, "Application of combinatorial testing to quantum programs," in *2021 IEEE 21st International Conference on Software Quality, Reliability and Security (QRS)*, 2021, pp. 179–188.
- [11] J. Ye, S. Xia, F. Zhang, P. Arcaini, L. Ma, J. Zhao, and F. Ishikawa, "QuraTest: Integrating quantum specific features in quantum program testing," in *2023 38th IEEE/ACM International Conference on Automated Software Engineering (ASE)*, 2023, pp. 1149–1161.
- [12] P. Zhao, J. Zhao, Z. Miao, and S. Lan, "Bugs4Q: A benchmark of real bugs for quantum programs," in *2021 36th IEEE/ACM International Conference on Automated Software Engineering (ASE)*, 2021, pp. 1373–1376.
- [13] P. Zhao, Z. Miao, S. Lan, and J. Zhao, "Bugs4Q: A benchmark of existing bugs to enable controlled testing and debugging studies for quantum programs," *Journal of Systems and Software*, vol. 205, p. 111805, 2023.
- [14] J. Campos and A. Souto, "QBugs: A collection of reproducible bugs in quantum algorithms and a supporting infrastructure to enable controlled quantum software testing and debugging experiments," in *2021 IEEE/ACM 2nd International Workshop on Quantum Software Engineering (Q-SE)*. Los Alamitos, CA, USA: IEEE Computer Society, 6 2021, pp. 28–32.
- [15] G. Pontolillo and M. R. Mousavi, "A multi-lingual benchmark for property-based testing of quantum programs," in *Proceedings of the 3rd International Workshop on Quantum Software Engineering*, ser. Q-SE '22. New York, NY, USA: Association for Computing Machinery, 2023, pp. 1–7.
- [16] E. Mendiluze Usandizaga, S. Ali, P. Arcaini, and T. Yue, "Muskit: A mutation analysis tool for quantum software testing," in *Proceedings of the 36th IEEE/ACM International Conference on Automated Software Engineering*, ser. ASE '21. IEEE Press, 2022, pp. 1266–1270.
- [17] E. Mendiluze Usandizaga, T. Yue, P. Arcaini, and S. Ali, "Supplementary material for the paper "Which Quantum Circuit Mutants Shall Be Used? An Empirical Evaluation of Quantum Circuit Mutations"," 2023. [Online]. Available: <https://github.com/EnautMendi/Which-Quantum-Circuit-Mutants-Shall-Be-Used>
- [18] N. S. Yanofsky and M. A. Mannucci, *Quantum computing for computer scientists*. Cambridge University Press, 2008.
- [19] W. K. Wootters and W. H. Zurek, "A single quantum cannot be cloned," *Nature*, vol. 299, no. 5886, pp. 802–803, 10 1982.
- [20] H. M. Wiseman and G. J. Milburn, *Quantum measurement and control*. Cambridge university press, 2009.
- [21] IBM, "Ibm quantum composer," 2023.
- [22] P. Ammann and J. Offutt, *Introduction to software testing*. Cambridge University Press, 2016.
- [23] J. Zhao, "Quantum software engineering: Landscapes and horizons," *CoRR*, vol. abs/2007.07047, 2020. [Online]. Available: <https://arxiv.org/abs/2007.07047>
- [24] A. García de la Barrera, I. García-Rodríguez de Guzmán, M. Polo, and M. Piattini, "Quantum software testing: State of the art," *Journal of Software: Evolution and Process*, vol. 35, no. 4, p. e2419, 2023.
- [25] M. Woodward, "Mutation testing—its origin and evolution," *Information and Software Technology*, vol. 35, no. 3, pp. 163–169, 1993.
- [26] A. Estero-Botaro, F. Palomo-Lozano, and I. Medina-Bulo, "Quantitative evaluation of mutation operators for WS-BPEL compositions," in *2010 Third International Conference on Software Testing, Verification, and Validation Workshops*, 2010, pp. 142–150.
- [27] M. Papadakis, C. Henard, M. Harman, Y. Jia, and Y. Le Traon, "Threats to the validity of mutation-based test assessment," in *Proceedings of the 25th International Symposium on Software Testing and Analysis*, ser. ISSTA 2016. New York, NY, USA: Association for Computing Machinery, 2016, pp. 354–365.
- [28] M. Papadakis, Y. Jia, M. Harman, and Y. Le Traon, "Trivial compiler equivalence: A large scale empirical study of a simple, fast and effective equivalent mutant detection technique," in *2015 IEEE/ACM 37th IEEE International Conference on Software Engineering*, vol. 1, 2015, pp. 936–946.
- [29] Y. Jia and M. Harman, "Higher order mutation testing," *Information and Software Technology*, vol. 51, no. 10, pp. 1379–1393, 2009.
- [30] M. Kintis, M. Papadakis, and N. Malevris, "Evaluating mutation testing alternatives: A collateral experiment," in *2010 Asia Pacific Software Engineering Conference*. IEEE, 2010, pp. 300–309.
- [31] X. Wang, P. Arcaini, T. Yue, and S. Ali, "Quito: A coverage-guided test generator for quantum programs," in *Proceedings of the 36th IEEE/ACM International Conference on Automated Software Engineering*, ser. ASE '21. IEEE Press, 2022, pp. 1237–1241.
- [32] Y. Jia and M. Harman, "An analysis and survey of the development of mutation testing," *IEEE Transactions on Software Engineering*, vol. 37, no. 5, pp. 649–678, 2011.
- [33] M. Papadakis, M. Kintis, J. Zhang, Y. Jia, Y. Le Traon, and M. Harman, "Chapter six - mutation testing advances: An analysis and survey," ser. Advances in Computers, A. M. Memon, Ed. Elsevier, 2019, vol. 112, pp. 275–378.
- [34] P. Anbalagan and T. Xie, "Automated generation of pointcut mutants for testing pointcuts in AspectJ programs," in *2008 19th International Symposium on Software Reliability Engineering (ISSRE)*, 2008, pp. 239–248.
- [35] J. Boubeta-Puig, I. Medina-Bulo, and A. García-Domínguez, "Analogies and differences between mutation operators for WS-BPEL 2.0 and other languages," in *2011 IEEE Fourth International Conference on Software Testing, Verification and Validation Workshops*, 2011, pp. 398–407.
- [36] A. Estero-Botaro, F. Palomo-Lozano, and I. Medina-Bulo, "Quantitative evaluation of mutation operators for WS-BPEL compositions," in *2010 Third International Conference on Software Testing, Verification, and Validation Workshops*, 2010, pp. 142–150.
- [37] S. Mirshokraie, A. Mesbah, and K. Pattabiraman, "Guided mutation testing for javascript web applications," *IEEE Transactions on Software Engineering*, vol. 41, no. 5, pp. 429–444, 2015.
- [38] P. Delgado-Pérez, S. Segura, and I. Medina-Bulo, "Assessment of C++ object-oriented mutation operators: A selective mutation approach," *Software Testing, Verification and Reliability*, vol. 27, no. 4-5, p. e1630, 2017.
- [39] J. Hu, N. Li, and J. Offutt, "An analysis of OO mutation operators," in *2011 IEEE Fourth International Conference on Software Testing, Verification and Validation Workshops*, 2011, pp. 334–341.
- [40] F. C. Ferrari, J. C. Maldonado, and A. Rashid, "Mutation testing for aspect-oriented programs," in *2008 1st International Conference on Software Testing, Verification, and Validation*, 2008, pp. 52–61.
- [41] L. Bottaci, "Type sensitive application of mutation operators for dynamically typed programs," in *2010 Third International Conference on Software Testing, Verification, and Validation Workshops*, 2010, pp. 126–131.
- [42] M. Gligoric, S. Badame, and R. Johnson, "SMutant: A tool for type-sensitive mutation testing in a dynamic language," in *Proceedings of the 19th ACM SIGSOFT Symposium and the 13th European Conference on Foundations of Software Engineering*, ser. ESEC/FSE '11. New York, NY, USA: Association for Computing Machinery, 2011, pp. 424–427.
- [43] A. Alberto, A. Cavalcanti, M. Gaudel, and A. Simão, "Formal mutation testing for Circus," *Information and Software Technology*, vol. 81, pp. 131–153, 2017.
- [44] U. Praphamontripong and J. Offutt, "Applying mutation testing to web applications," in *2010 Third International Conference on Software Testing, Verification, and Validation Workshops*, 2010, pp. 132–141.
- [45] U. Praphamontripong, J. Offutt, L. Deng, and J. Gu, "An experimental evaluation of web mutation operators," in *2016 IEEE Ninth International Conference on Software Testing, Verification and Validation Workshops (ICSTW)*, 2016, pp. 102–111.
- [46] L. Deng, N. Mirzaei, P. Ammann, and J. Offutt, "Towards mutation analysis of Android apps," in *2015 IEEE Eighth International Conference on Software Testing, Verification and Validation Workshops (ICSTW)*, 2015, pp. 1–10.
- [47] M. P. Usaola, G. Rojas, I. Rodríguez, and S. Hernández, "An architecture for the development of mutation operators," in *2017 IEEE International Conference on Software Testing, Verification and Validation Workshops (ICSTW)*, 2017, pp. 143–148.
- [48] R. A. Oliveira, E. Alégroth, Z. Gao, and A. Memon, "Definition and evaluation of mutation operators for GUI-level mutation analysis," in *2015 IEEE Eighth International Conference on Software Testing, Verification and Validation Workshops (ICSTW)*, 2015, pp. 1–10.
- [49] F. Wu, J. Nanavati, M. Harman, Y. Jia, and J. Krinke, "Memory mutation testing," *Information and Software Technology*, vol. 81, pp. 97–111, 2017.
- [50] M. E. Delamaro, J. Offutt, and P. Ammann, "Designing deletion mutation operators," in *2014 IEEE Seventh International Conference on Software Testing, Verification and Validation*, 2014, pp. 11–20.
- [51] R. Gopinath and E. Walkingshaw, "How good are your types? using mutation analysis to evaluate the effectiveness of type annotations," in *2017 IEEE International Conference on Software Testing, Verification and Validation Workshops (ICSTW)*, 2017, pp. 122–127.
- [52] P. Arcaini, A. Gargantini, and E. Riccobene, "MutRex: A mutation-based generator of fault detecting strings for regular expressions," in *2017 IEEE International Conference on Software Testing, Verification and Validation Workshops (ICSTW)*, 2017, pp. 87–96.
- [53] ——, "Fault-based test generation for regular expressions by mutation," *Software Testing, Verification and Reliability*, vol. 29, no. 1-2, p. e1664, 2019.
- [54] L. Zhang, S.-S. Hou, J.-J. Hu, T. Xie, and H. Mei, "Is operator-based mutant selection superior to random mutant selection?" in *Proceedings of the 32nd ACM/IEEE International Conference on Software Engineering - Volume 1*, ser. ICSE '10. New York, NY, USA: Association for Computing Machinery, 2010, pp. 435–444.
- [55] R. Gopinath, A. Alipour, I. Ahmed, C. Jensen, and A. Groce, "How hard does mutation analysis have to be, anyway?" in *2015 IEEE 26th International Symposium on Software Reliability Engineering (ISSRE)*, 2015, pp. 216–227.
- [56] A. Siami Namin, J. H. Andrews, and D. J. Murdoch, "Sufficient mutation operators for measuring test effectiveness," in *Proceedings of the 30th International Conference on Software Engineering*, ser. ICSE '08. New York, NY, USA: Association for Computing Machinery, 2008, pp. 351–360.
- [57] M. E. Delamaro, L. Deng, V. H. S. Durelli, N. Li, and J. Offutt, "Experimental evaluation of SDL and one-op mutation for C," in *2014 IEEE Seventh International Conference on Software Testing, Verification and Validation*, 2014, pp. 203–212.
- [58] V. H. S. Durelli, N. M. De Souza, and M. E. Delamaro, "Are deletion mutants easier to identify manually?" in *2017 IEEE International Conference on Software Testing, Verification and Validation Workshops (ICSTW)*, 2017, pp. 149–158.
- [59] X. Yao, M. Harman, and Y. Jia, "A study of equivalent and stubborn mutation operators using human analysis of equivalence," in *Proceedings of the 36th International Conference on Software Engineering*, ser. ICSE 2014. New York, NY, USA: Association for Computing Machinery, 2014, pp. 919–930.
- [60] B. H. Smith and L. Williams, "An empirical evaluation of the MuJava mutation operators," in *Testing: Academic and Industrial Conference Practice and Research Techniques-MUTATION (TAICPART-MUTATION 2007)*. IEEE, 2007, pp. 193–202.
- [61] Y.-S. Ma, J. Offutt, and Y.-R. Kwon, "MuJava: A mutation system for Java," in *Proceedings of the 28th International Conference on Software Engineering*, ser. ICSE '06. New York, NY, USA: Association for Computing Machinery, 2006, pp. 827–830.
- [62] R. Just, D. Jalali, L. Inozemtseva, M. D. Ernst, R. Holmes, and G. Fraser, "Are mutants a valid substitute for real faults in software testing?" in *Proceedings of the 22nd ACM SIGSOFT International Symposium on Foundations of Software Engineering*, ser. FSE 2014. New York, NY, USA: Association for Computing Machinery, 2014, pp. 654–665.
- [63] H. Zhang, T. Yue, S. Ali, and C. Liu, "Towards mutation analysis for use cases," in *Proceedings of the ACM/IEEE 19th International Conference on Model Driven Engineering Languages and Systems*, ser. MODELS '16. New York, NY, USA: Association for Computing Machinery, 2016, pp. 363–373.
- [64] P. Zhao, J. Zhao, and L. Ma, "Identifying bug patterns in quantum programs," in *2021 IEEE/ACM 2nd International Workshop on Quantum Software Engineering (Q-SE)*. Los Alamitos, CA, USA: IEEE Computer Society, 6 2021, pp. 16–21.
- [65] C. A. R. Hoare, "An axiomatic basis for computer programming," *Commun. ACM*, vol. 12, no. 10, pp. 576–580, oct 1969.
- [66] R. Abreu, J. P. Fernandes, L. Llana, and G. Tavares, "Metamorphic testing of oracle quantum programs," in *2022 IEEE/ACM 3rd International Workshop on Quantum Software Engineering (Q-SE)*, 2022, pp. 16–23.
- [67] M. Lewis, S. Soudjani, and P. Zuliani, "Formal verification of quantum programs: Theory, tools, and challenges," *ACM Transactions on Quantum Computing*, vol. 5, no. 1, pp. 1–35, 2023.
- [68] R. Rand, J. Paykin, and S. Zdancewic, "QWIRE practice: Formal verification of quantum circuits in Coq," *arXiv preprint arXiv:1803.00699*, 2018.
- [69] K. Hietala, R. Rand, S.-H. Hung, L. Li, and M. Hicks, "Proving quantum programs correct," *arXiv preprint arXiv:2010.01240*, 2020.
- [70] A. C. Rao, A. Raouf, G. Dhadyalla, and V. Pasupuleti, "Mutation testing based evaluation of formal verification tools," in *2017 International Conference on Dependable Systems and Their Applications (DSA)*, 2017, pp. 1–7.
- [71] K. Jain, K. Palmskog, A. Celik, E. J. G. Arias, and M. Gligoric, "mcoq: mutation analysis for coq verification projects," in *Proceedings of the ACM/IEEE 42nd International Conference on Software Engineering: Companion Proceedings*, ser. ICSE '20. New York, NY, USA: Association for Computing Machinery, 2020, pp. 89–92. [Online]. Available: <https://doi.org/10.1145/3377812.3382156>
- [72] J. L. Weaver and F. J. Harkins, *Qiskit Pocket Guide*. O'Reilly Media, Inc., 2022.
- [73] N. Quetschlich, L. Burgholzer, and R. Wille, "MQT Bench: Benchmarking software and design automation tools for quantum computing," *Quantum*, 2023, MQT Bench is available at [https://www.cda.cit.tum.de/mqtbench/.](https://www.cda.cit.tum.de/mqtbench/)
- [74] U. Azad, A. Papneja, R. Saini, B. K. Behera, and P. K. Panigrahi, "Circuit centric quantum architecture design," *IET Quantum Communication*, vol. 2, no. 1, pp. 14–25, 2021.
- [75] A. Li, S. Stein, S. Krishnamoorthy, and J. Ang, "QASMBench: A low-level quantum benchmark suite for nisq evaluation and simulation," *ACM Transactions on Quantum Computing*, vol. 4, no. 2, 2 2023.
- [76] A. M. Childs, E. Schoute, and C. M. Unsal, "Circuit Transformations for Quantum Architectures," in *14th Conference on the Theory of Quantum Computation, Communication and Cryptography (TQC 2019)*, ser. Leibniz International Proceedings in Informatics (LIPIcs), W. van Dam and L. Mančinska, Eds., vol. 135. Dagstuhl, Germany: Schloss Dagstuhl – Leibniz-Zentrum für Informatik, 2019, pp. 3:1–3:24.
- [77] T. J. Cleophas and A. H. Zwinderman, *Bayesian Pearson Correlation Analysis*. Cham: Springer International Publishing, 2018, pp. 111–118.
- [78] A. W. Cross, L. S. Bishop, J. A. Smolin, and J. M. Gambetta, "Open quantum assembly language," *arXiv preprint arXiv:1707.03429*, 2017.
- [79] J. Domínguez-Jiménez, A. Estero-Botaro, A. García-Domínguez, and I. Medina-Bulo, "Evolutionary mutation testing," *Information and Software Technology*, vol. 53, no. 10, pp. 1108–1123, 2011, special Section on Mutation Testing.

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- [80] G. Mogos, "Quantum random number generator vs. random number generator," in *2016 International Conference on Communications (COMM)*, 2016, pp. 423–426.
- [81] A. J. Offutt, "Investigations of the software testing coupling effect," *ACM Trans. Softw. Eng. Methodol.*, vol. 1, no. 1, pp. 5–20, jan 1992.